

Title: METHOD AND ARRANGEMENT FOR TRANSPORTING AND INSPECTING SEMICONDUCTOR SUBSTRATES Inventor(s): Andreas BIRKNER et al. DOCKET NO.: 016790-0488

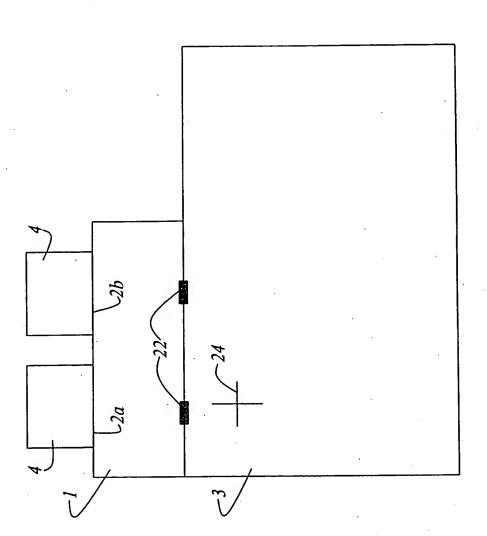
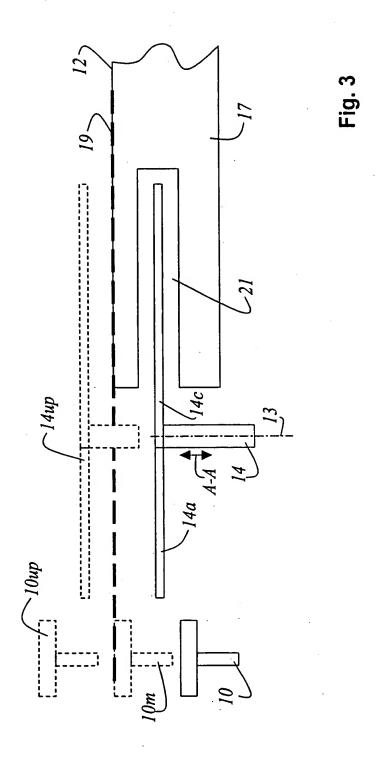


Fig. 2



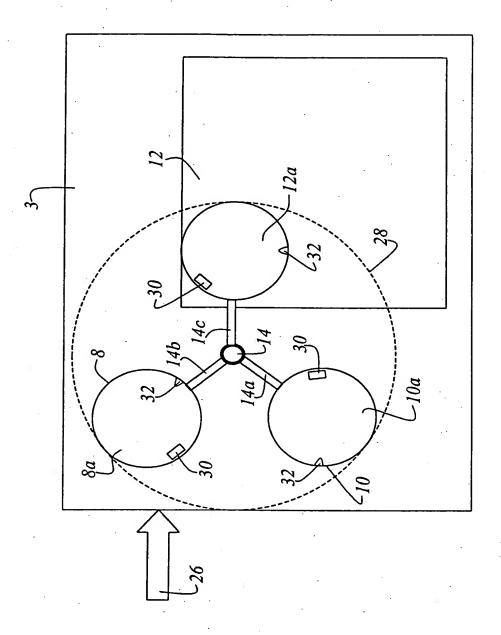


Fig. 4

